2SC3980

Silicon NPN triple diffusion planar type

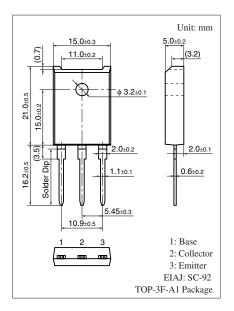
For high breakdown voltage high-speed switching

■ Features

- High-speed switching
- High collector-base voltage (Emitter open) V_{CBO}
- Wide safe operation area
- Satisfactory linearity of forward current transfer ratio h_{FE}
- Full-pack package which can be installed to the heat sink with one screw

■ Absolute Maximum Ratings $T_C = 25$ °C

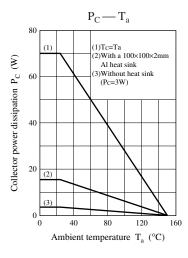
Parameter	Symbol	Rating	Unit	
Collector-base voltage (En	V _{CBO}	900	V	
Collector-emitter voltage (E-B short)		V _{CES}	900	V
Collector-emitter voltage (Base open)		V _{CEO}	800	V
Emitter-base voltage (Collector open)		V _{EBO}	7	V
Base current		I_B	2	A
Collector current	I_C	4	A	
Peak collector current		I_{CP}	6	A
Collector power		P _C	70	W
dissipation	$T_a = 25^{\circ}C$		3.0	
Junction temperature	T_{j}	150	°C	
Storage temperature		T_{stg}	-55 to +150	°C

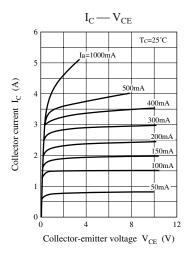


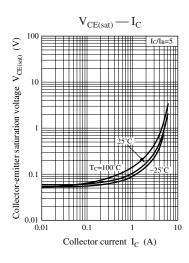
■ Electrical Characteristics $T_C = 25$ °C ± 3 °C

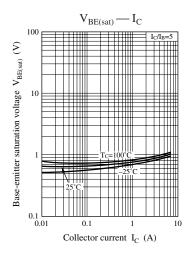
Parameter	Symbol	Conditions	Min	Тур	Max	Unit
Collector-emitter voltage (Base open)	V _{CEO}	$I_C = 10 \text{ mA}, I_B = 0$	800			V
Collector-base cutoff current (Emitter open)	I_{CBO}	$V_{CB} = 900 \text{ V}, I_{E} = 0$			50	μΑ
Emitter-base cutoff current (Collector open)	I _{EBO}	$V_{EB} = 7 \text{ V}, I_{C} = 0$			50	μΑ
Forward current transfer ratio	h _{FE1}	$V_{CE} = 5 \text{ V}, I_{C} = 0.1 \text{ A}$	8			_
	h _{FE2}	$V_{CE} = 5 \text{ V}, I_{C} = 2 \text{ A}$	6			
Collector-emitter saturation voltage	V _{CE(sat)}	$I_C = 2 A, I_B = 0.4 A$			1.5	V
Base-emitter saturation voltage	V _{BE(sat)}	$I_C = 2 A, I_B = 0.4 A$			1.5	V
Transition frequency	f_T	$V_{CE} = 5 \text{ V}, I_{C} = 0.2 \text{ A}, f = 1 \text{ MHz}$		15		MHz
Turn-on time	t _{on}	$I_C = 2 A$			0.7	μs
Storage time	t _{stg}	$I_{B1} = 0.4 \text{ A}, I_{B2} = -0.8 \text{ A}$			2.5	μs
Fall time	t _f	$V_{CC} = 250 \text{ V}$			0.3	μs

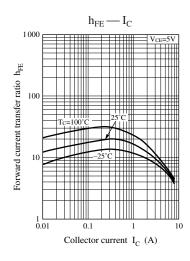
Note) Measuring methods are based on JAPANESE INDUSTRIAL STANDARD JIS C 7030 measuring methods for transistors.

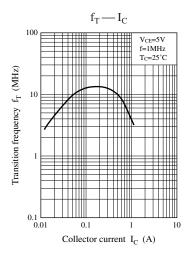


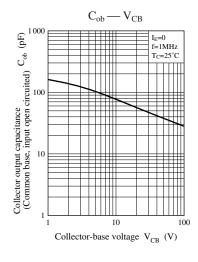


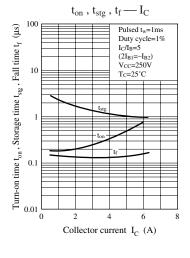


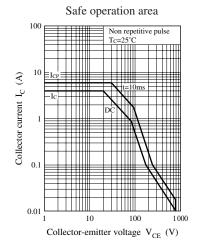




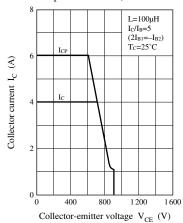




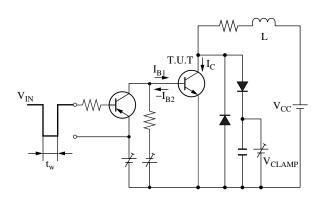


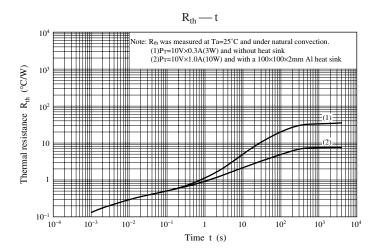


Safe operation area (Reverse bias)



Safe operation area (Reverse bias) measurement circuit





SJD00123BED 3

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